

EMC Test Report

Application No. : HX2002094157
Applicant : Shenzhen Chenruixin Electronic Technology Co, Ltd
Equipment Under Test (EUT)
EUT Name : Infrared Thermometer
Model No. : CR-D815
Serial No. : See Page 3
Brand Name : 晨瑞欣
Receipt Date : 2020-02-27
Test Date : 2020-02-27 to 2020-03-04
Issue Date : 2020-03-04
Standards : EN 61000-6-3: 2007+A1: 2011;
EN 61000-6-1: 2007.
Conclusions : **PASS**

In the configuration tested, the EUT complied with the standards specified above, The EUT technically complies with the 2014/30/EU directive requirements.

Test/Witness Engineer

Tim Chen

Approved & Authorized

Andy Zhang



This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.

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1. General Information

1.1. Client Information

Applicant	:	Shenzhen Chenruixin Electronic Technology Co, Ltd
Address	:	Floor 6,Block 2,Huafeng Technology Park,Gushu,Bao'an District, Shenzhen City, Guangdong Prov.
Manufacturer	:	Shenzhen Chenruixin Electronic Technology Co, Ltd
Address	:	Floor 6,Block 2,Huafeng Technology Park,Gushu,Bao'an District, Shenzhen City, Guangdong Prov.

1.2. General Description of EUT (Equipment Under Test)

EUT Name	:	Infrared Thermometer
Model No.	:	CR-D815
Serial No.	:	BT-T1009, BT-1008, BT-T1010, BT-T2098, BT-T2090, BT-T1090
Brand Name	:	晨瑞欣
Power supply	:	DC 3.0V, 0.1A
<p>Remark: All above models are identical in schematic, structure and critical components except for only different appearance; therefore, EMC testing was performed with BT-T2099 only.</p>		

1.3. Block Diagram Showing The Configuration of System Tested



1.4. Description of Support Units

The EUT has been tested as an independent unit.

1.5. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

1.6. Test Facility

The testing report were performed by the Shenzhen HX Detect Certification Co., Ltd., in their facilities located at 5/F, Building B15, Zongtai Cultural and Creative Industrial Park, Yintian Creative Park, Xixiang Town, Bao 'an District, Shenzhen.

2. TEST Results Summary

EMISSION		
Description of test items	Standards	Results
Conducted disturbance at mains terminals	EN 61000-6-3: 2007+A1: 2011	N/A
Radiated Disturbance	EN 61000-6-3: 2007+A1: 2011	Pass
Harmonic current emissions	EN 61000-3-2: 2014	N/A
Voltage fluctuation and flicker	EN 61000-3-3: 2013	N/A
IMMUNITY		
Description of test items	Standards	Results
Electrostatic Discharge (ESD)	EN 61000-4-2: 2009	Pass
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A1: 2008 +A2:2010	Pass
EFT/B Immunity	EN 61000-4-4: 2004+A1: 2010	N/A
Surge Immunity	EN 61000-4-5: 2014	N/A
Conducted RF Immunity	EN 61000-4-6: 2014	N/A
Power frequency magnetic field	EN 61000-4-8: 2010	N/A
Voltage dips, >95% reduction	EN 61000-4-11: 2004	N/A
Voltage dips, 30% reduction		
Voltage interruptions		
Note: N/A is an abbreviation for Not Applicable.		

3. Test Equipment Used

3.1. Test Equipment Used to Measure Conducted Emission					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan.02, 2020	1 Year
HX-EMC002	AMN	Rohde & Schwarz	ENV216	Jan.02, 2020	1 Year
HX-EMC003	AMN	SCHWARZBECK	NNBL 8226	Jan.02, 2020	1 Year
3.2. Test Equipment Used to Measure Radiated Emission					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC004	EMI Test Receiver	Rohde & Schwarz	ESI26	Jan.02, 2020	1 Year
HX-EMC005	Bilog Antenna	SCHWARZBECK	VULB9163	Jan.02, 2020	1 Year
HX-EMC006	Positioning Controller	C&C	CC-C-1F	N/A	N/A
3.3. Test Equipment Used to Measure Harmonic Current/ Voltage Fluctuation and Flicker					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC007	Harmonic Flicker Test System	CI	5001ix-CTS-400	Jan.02, 2020	1 Year
3.4. Test Equipment Used to Measure Electrostatic Discharge Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC008	ESD Tester	TESEQ	NSG437	Jan.02, 2020	1 Year
3.5. Test Equipment Used to Measure Conducted Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC009	RF Generator	FRANKONIA	CIT-10/75	Jan.02, 2020	1 Year
HX-EMC010	Attenuator	FRANKONIA	59-6-33	Jan.02, 2020	1 Year
HX-EMC011	M-CDN	LUTHI	M2/M3	Jan.02, 2020	1 Year
HX-EMC012	CDN	LUTHI	AF2	Jan.02, 2020	1 Year
HX-EMC013	EM Injection Clamp	LUTHI	EM101	Jan.02, 2020	1 Year
3.6. Test Equipment Used to Measure Radio Frequency Electromagnetic Fields Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC014	Signal Generator	Rohde & Schwarz	SMT03	Jan.02, 2020	1 Year

HX-EMC015	Power Meter	Rohde & Schwarz	NRVD	Jan.02, 2020	1 Year
HX-EMC016	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.02, 2020	1 Year
HX-EMC017	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan.02, 2020	1 Year
HX-EMC018	Power Amplifier	AR	150W1000	Jan.02, 2020	1 Year
HX-EMC019	Bilog Antenna	Chase	CBL6111C	Jan.02, 2020	1 Year

3.7. Test Equipment Used to Measure Electrical Fast Transient/Burst Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC020	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC021	Auto-transformer	EMTEST	V4780S2	Jan.02, 2020	1 Year

3.8. Test Equipment Used to Measure Surge Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.02, 2020	1 Year

3.9. Test Equipment Used to Measure Voltage Dips and Interruptions Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan.02, 2020	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan.02, 2020	1 Year

3.10. Test Equipment Used to Measure Power frequency Magnetic Field

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC026	Power Frequency Magnetic Field Generator	EVERFINE	EMS61000-8	Jan.02, 2020	1 Year

4. Radiated Emission Test

4.1. Test Standard and Limit

4.1.1. Test Standard

EN 61000-6-3: 2007+A1:2011

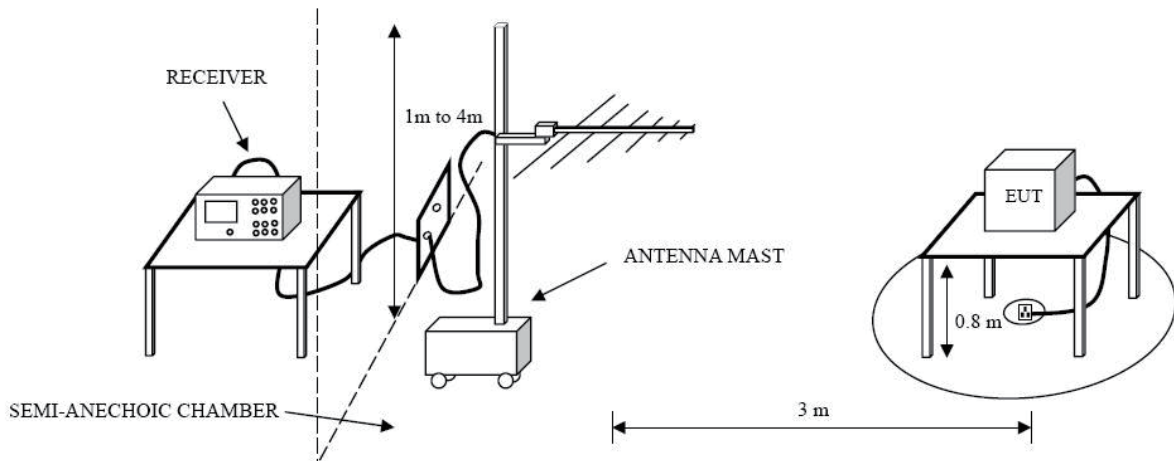
4.1.2. Test Limit

Radiated Disturbance Test Limit

Frequency	Limit (dB μ V/m)
	Quasi-peak Level
30MHz~230MHz	40
230MHz~1000MHz	47

Remark: 1. The lower limit shall apply at the transition frequency.
2. The test distance is 3m.

4.2



4.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

4.4. Test Condition

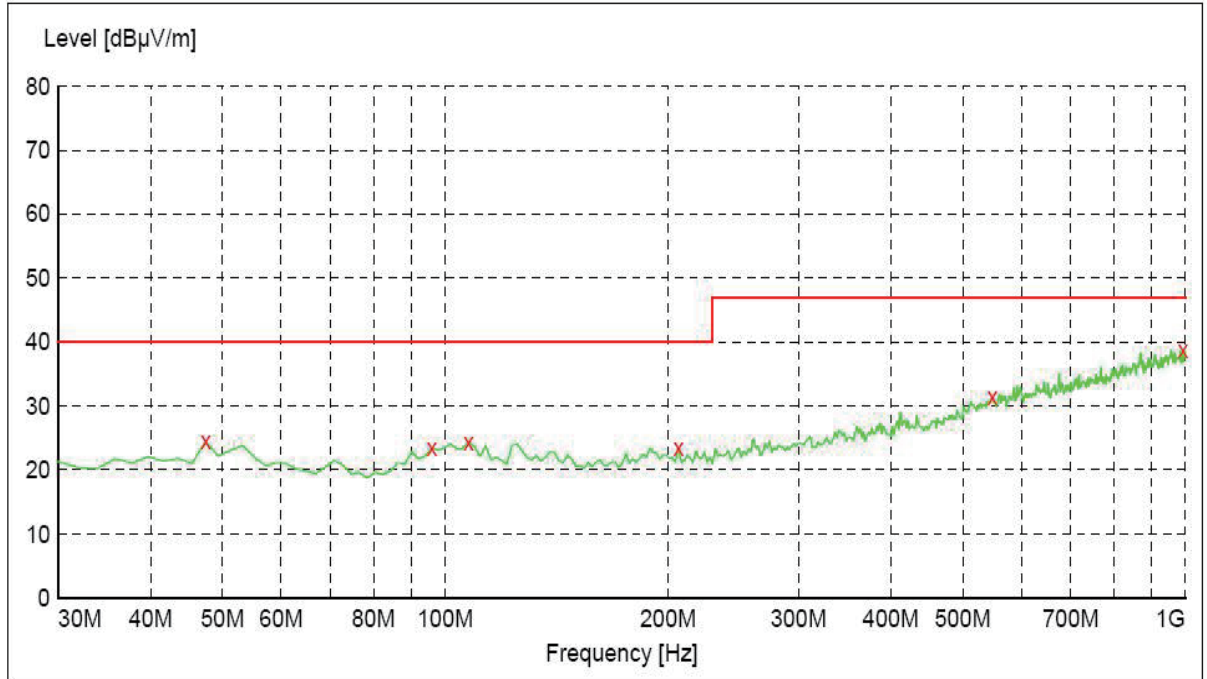
Temperature	:	23 °C
Relative Humidity	:	52 %
Pressure	:	1010 hPa
Test Power	:	DC 3V

4.5. Test Data

Please refer to the following pages.

Operating Condition: Normal

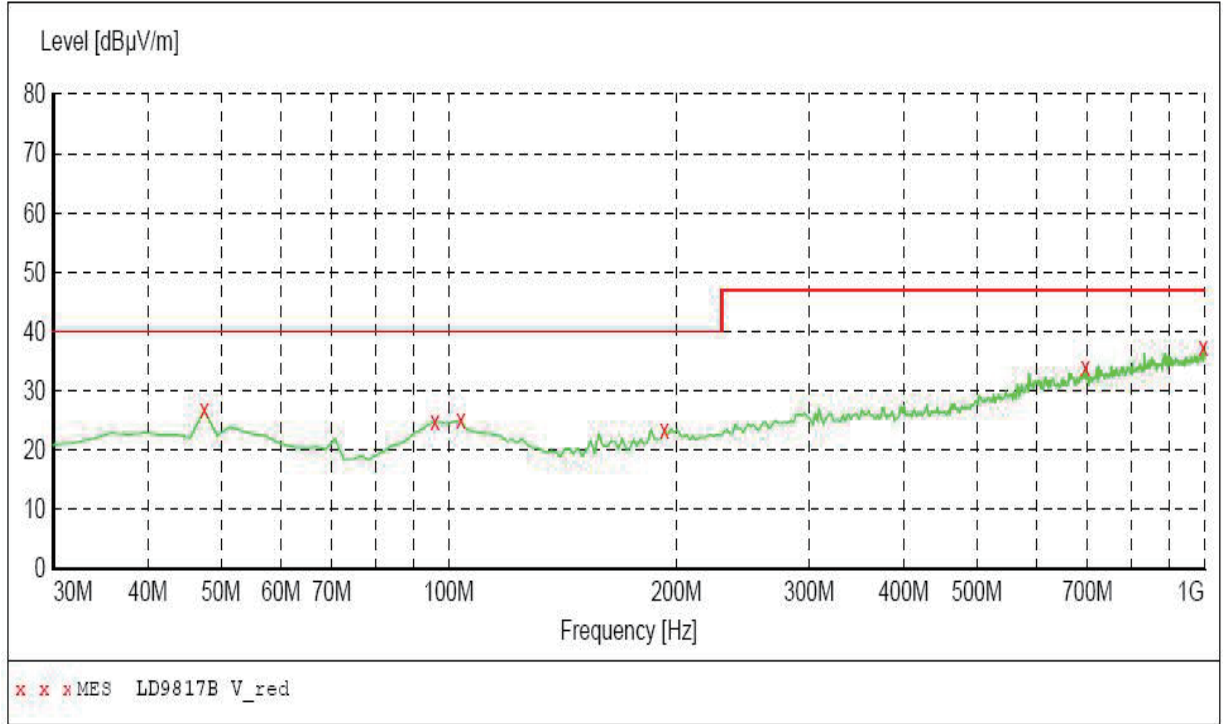
Test Specification: Horizontal



Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.	Height cm	Azimuth deg	Polarization
47.460000	24.50	15.8	40.0	15.5	---	100.0	0.00	HORIZONTAL
95.960000	23.50	17.2	40.0	16.5	---	100.0	0.00	HORIZONTAL
107.600000	24.40	16.9	40.0	15.6	---	100.0	0.00	HORIZONTAL
206.540000	23.50	16.1	40.0	16.5	---	100.0	0.00	HORIZONTAL
547.980000	31.50	25.1	47.0	15.5	---	100.0	0.00	HORIZONTAL
992.240000	38.80	32.2	47.0	8.2	---	100.0	0.00	HORIZONTAL

Operating Condition: Normal

Test Specification: Vertical



Frequency MHz	Level dBµV/m	Transd dB	Limit dBµV/m	Margin dB	Det.	Height cm	Azimuth deg	Polarization
47.460000	26.80	16.7	40.0	13.2	---	100.0	0.00	VERTICAL
95.960000	24.80	18.0	40.0	15.2	---	100.0	0.00	VERTICAL
103.720000	25.10	18.1	40.0	14.9	---	100.0	0.00	VERTICAL
192.960000	23.60	16.8	40.0	16.4	---	100.0	0.00	VERTICAL
695.420000	34.00	26.6	47.0	13.0	---	100.0	0.00	VERTICAL
996.120000	37.40	30.0	47.0	9.6	---	100.0	0.00	VERTICAL

5. Electrostatic Discharge Immunity Test

5.1. Test Requirements

5.1.1. Test Standard

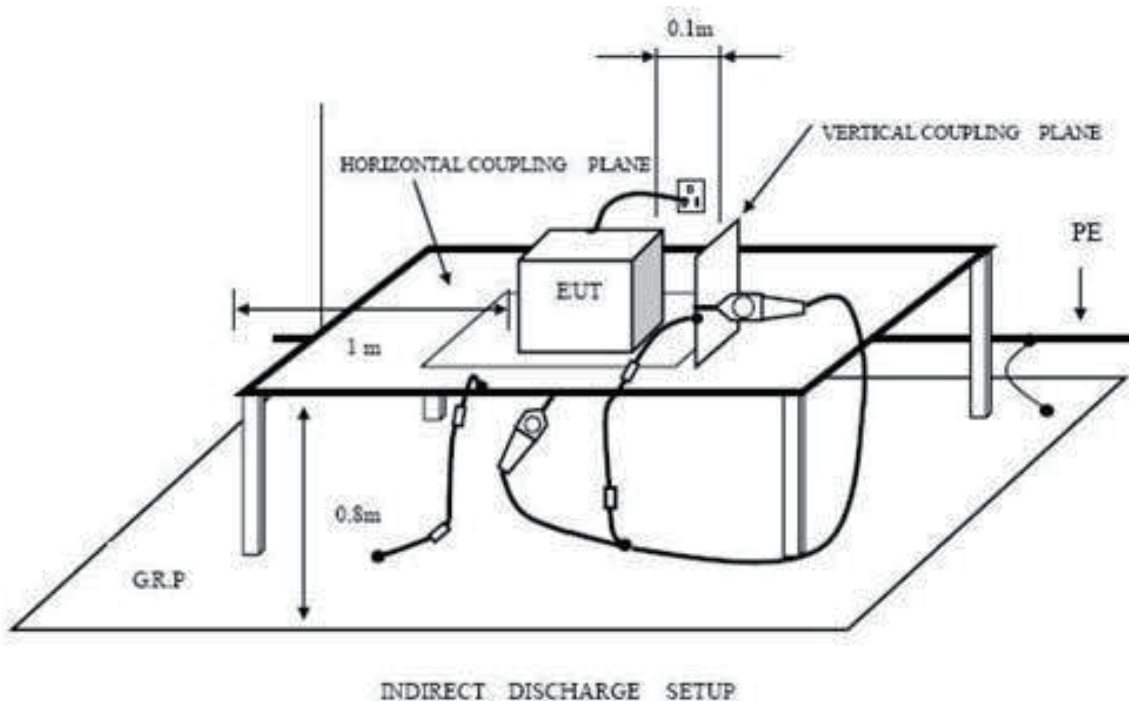
EN 61000-6-1: 2007 (EN 61000-4-2:2009)

5.1.2. Test Level

Level	Test Voltage Contact Discharge (kV)	Test Voltage Air Discharge (kV)
1	±2	±2
2	±4	±4
3	±6	±8
4	±8	±15
X	Special	Special

5.1.3. Performance criterion: **B**

5.2. Test Setup



5.3. Test Procedure

5.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

5.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

5.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

5.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

5.4. Test Data

Please refer to the following page.

Electrostatic Discharge Test Result

EUT : <u>Infrared Thermometer</u>	M/N : <u>BT-T2099</u>	
Temperature : <u>23°C</u>	Humidity : <u>53%</u>	
Power supply : <u>DC3V</u>	Test Mode : <u>Normal</u>	
Criterion: B		
Air Discharge: $\pm 8\text{kV}$ Contact Discharge: $\pm 4\text{kV}$ For each point positive 10 times and negative 10 times discharge.		
Location	Kind A-Air Discharge C-Contact Discharge	Result
Nonconductive Enclosure	A	PASS
Conductive Enclosure	C	PASS
Screw	C	PASS
HCP	C	PASS
VCP of front	C	PASS
VCP of rear	C	PASS
VCP of left	C	PASS
VCP of right	C	PASS

6. Radiated Electromagnetic Field Immunity Test

6.1. Test Requirements

6.1.1. Test Standard

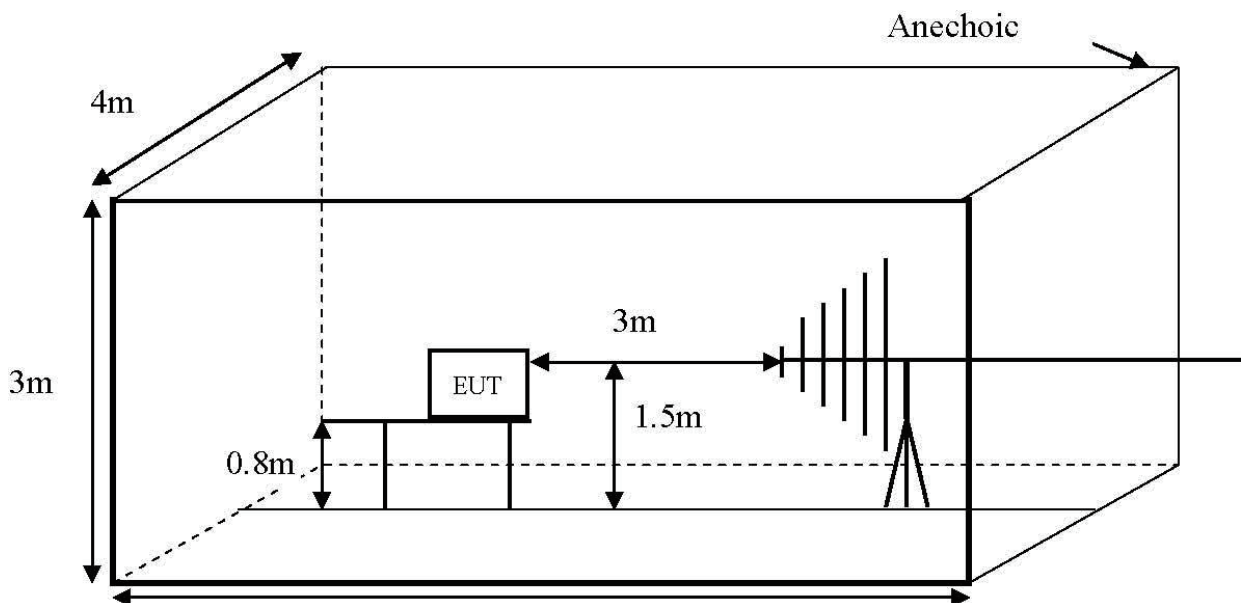
EN 61000-6-1: 2007 (EN 61000-4-3: 2006 + A1: 2008 + A2: 2010)

6.1.2. Test Level

Level	Field Strength V/m
1	1
2	3
3	10
X	Special

6.1.3. Performance criterion: **A**

6.2. Test Setup



6.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark
Fielded strength	3V/m (Severity Level 2)
Radiated signal	Modulated
Scanning frequency	80-1000MHz
Sweep time of radiated	0.0015 Decade/s
Dwell time	1 Sec.

6.4. Test Data

Please refer to the following page.

RF Field Strength Susceptibility Test Results

EUT	: <u>Infrared Thermometer</u>	M/N	: <u>BT-T2099</u>	
Temperature	: <u>23°C</u>	Humidity	: <u>53%</u>	
Power supply	: <u>DC3V</u>	Test Mode	: <u>Normal</u>	
Criterion: A				
Modulation: Unmodulated				
Pulse: AM 1KHz 80%				
	Frequency Range 1		Frequency Range 2	
	80~1000MHz		/	
	Horizontal	Vertical	Horizontal	Vertical
Front	PASS	PASS	/	/
Right	PASS	PASS	/	/
Rear	PASS	PASS	/	/
Left	PASS	PASS	/	/

7. Photographs - Constructional Details

Photo 1 Appearance of EUT



Photo 2 Appearance of EUT



Photo 3 Appearance of EUT



Photo 4 Appearance of EUT



END OF REPORT